

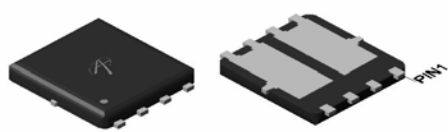
### General Description

The AON6884L uses advanced trench technology to provide excellent  $R_{DS(ON)}$  with low gate charge. This is an all purpose device that is suitable for use in a wide range of power conversion applications.

### Product Summary

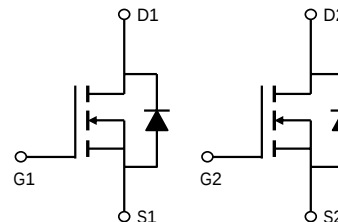
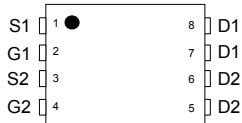
|                                    |                  |
|------------------------------------|------------------|
| $V_{DS}$                           | 40V              |
| $I_D$ (at $V_{GS}=10V$ )           | 34A              |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )    | < 11.3m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS} = 4.5V$ ) | < 13.8m $\Omega$ |

100% UIS Tested  
100%  $R_g$  Tested



DFN5X6 EP2

Top View



### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol           | Maximum    | Units            |
|------------------------------------------------|------------------|------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$         | 40         | V                |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 20$   | V                |
| Continuous Drain Current                       | $I_D$            | 34         | A                |
| $T_C=25^\circ\text{C}$                         |                  | 21         |                  |
| $T_C=100^\circ\text{C}$                        |                  |            |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$         | 120        |                  |
| Continuous Drain Current                       | $I_{DSM}$        | 9          | A                |
| $T_A=25^\circ\text{C}$                         |                  | 7          |                  |
| $T_A=70^\circ\text{C}$                         |                  |            |                  |
| Avalanche Current <sup>C</sup>                 | $I_{AS}, I_{AR}$ | 35         | A                |
| Avalanche energy $L=0.1\text{mH}$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 61         | mJ               |
| Power Dissipation <sup>B</sup>                 | $P_D$            | 21         | W                |
| $T_C=25^\circ\text{C}$                         |                  | 8          |                  |
| $T_C=100^\circ\text{C}$                        |                  |            |                  |
| Power Dissipation <sup>A</sup>                 | $P_{DSM}$        | 1.6        | W                |
| $T_A=25^\circ\text{C}$                         |                  | 1          |                  |
| $T_A=70^\circ\text{C}$                         |                  |            |                  |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 150 | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units              |
|--------------------------------------------|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 35  | 45  | $^\circ\text{C/W}$ |
| $t \leq 10\text{s}$                        |                 |     |     |                    |
| Maximum Junction-to-Ambient <sup>A D</sup> | $R_{\theta JC}$ | 65  | 80  | $^\circ\text{C/W}$ |
| Steady-State                               |                 |     |     |                    |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 5   | 6   | $^\circ\text{C/W}$ |
| Steady-State                               |                 |     |     |                    |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                              | Min  | Typ       | Max        | Units |
|-----------------------------|---------------------------------------|-----------------------------------------------------------------------------------------|------|-----------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                         |      |           |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                              | 40   |           |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =40V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                       |      |           | 1<br>5     | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V                                             |      |           | ±100       | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                | 1.55 | 2.1       | 2.7        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                               | 120  |           |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =10A<br>T <sub>J</sub> =125°C                      |      | 9.4<br>14 | 11.3<br>17 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A                                              |      | 11        | 13.8       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =10A                                                |      | 50        |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                 |      | 0.7       | 1          | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                         |      |           | 25         | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                         |      |           |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz                                       | 1200 | 1500      | 1950       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                         | 150  | 215       | 280        | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                         | 80   | 135       | 190        | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                        | 1.7  | 3.5       | 5.3        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                         |      |           |            |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =10A                         | 22   | 27.2      | 33         | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |                                                                                         | 10   | 13.6      | 16         | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                         | 3.6  | 4.5       | 5.4        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                         | 3.8  | 6.4       | 9          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, R <sub>L</sub> =2Ω,<br>R <sub>GEN</sub> =3Ω |      | 6.4       |            | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                         |      | 17.2      |            | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                         |      | 29.6      |            | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                         |      | 16.8      |            | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =10A, dI/dt=500A/μs                                                      | 9    | 13        | 17         | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =10A, dI/dt=500A/μs                                                      | 25   | 35        | 45         | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

G. The maximum current rating is limited by bond-wires.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

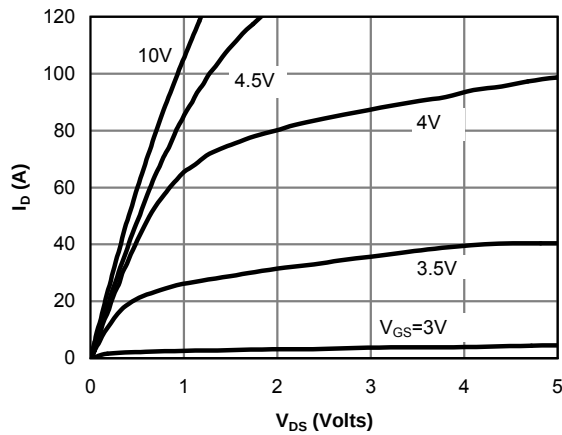


Fig 1: On-Region Characteristics (Note E)

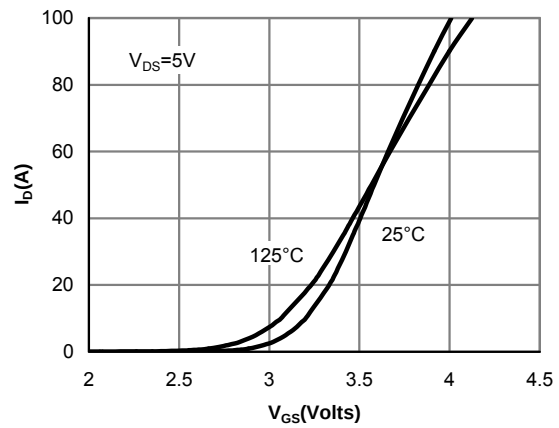


Figure 2: Transfer Characteristics (Note E)

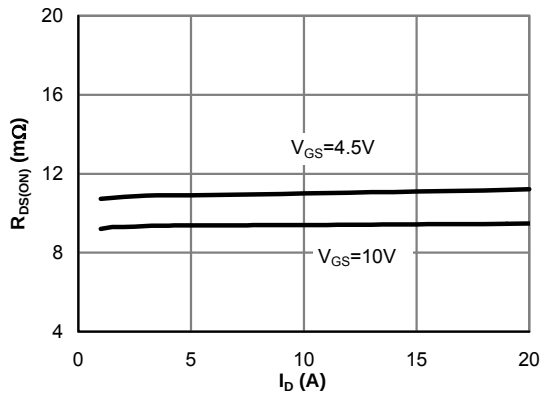


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

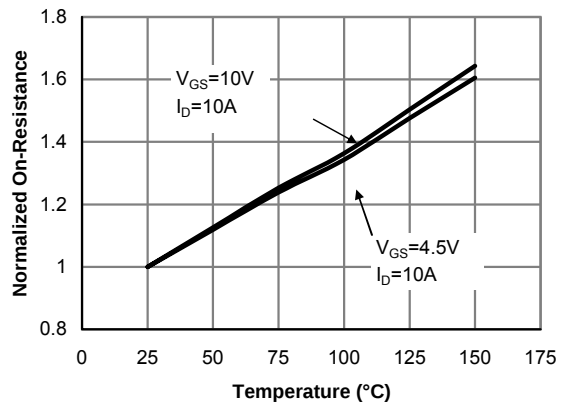


Figure 4: On-Resistance vs. Junction Temperature (Note E)

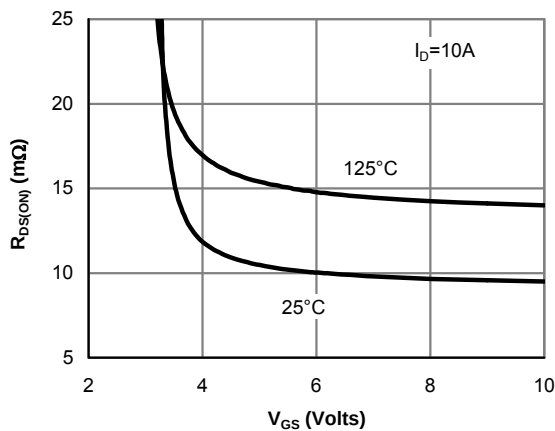


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

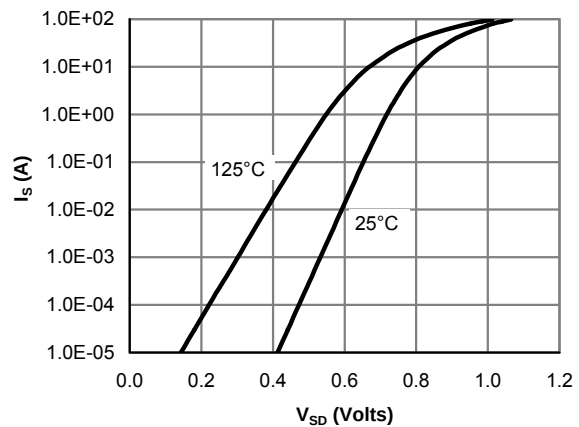
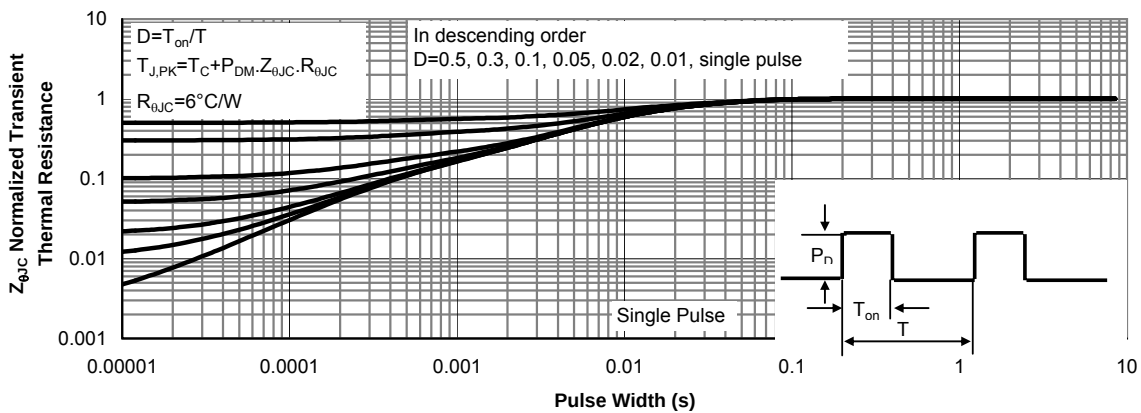
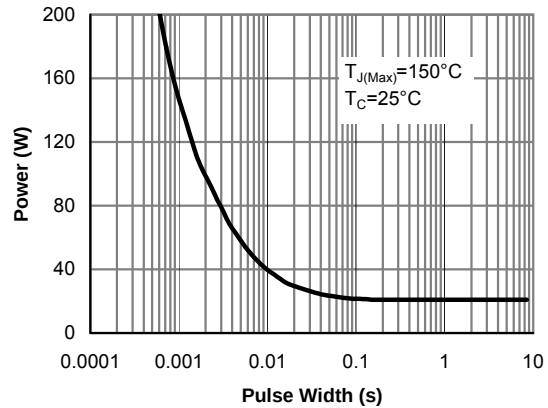
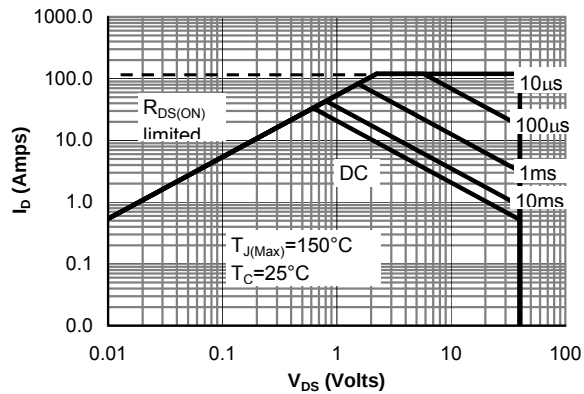
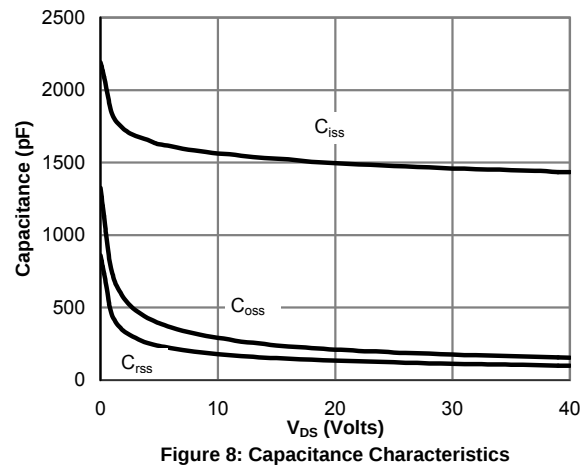
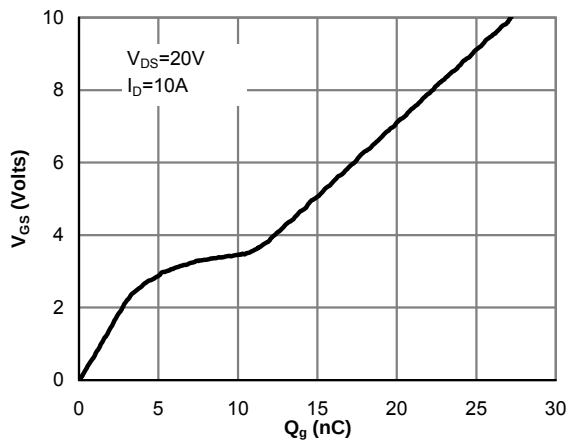


Figure 6: Body-Diode Characteristics (Note E)

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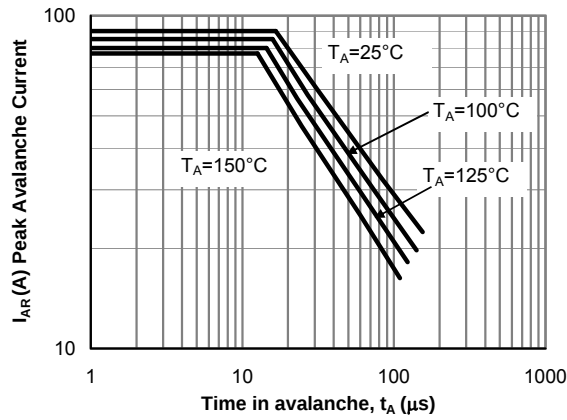


Figure 12: Single Pulse Avalanche capability (Note C)

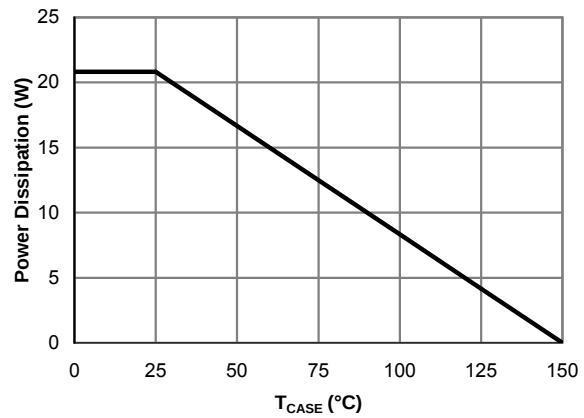


Figure 13: Power De-rating (Note F)

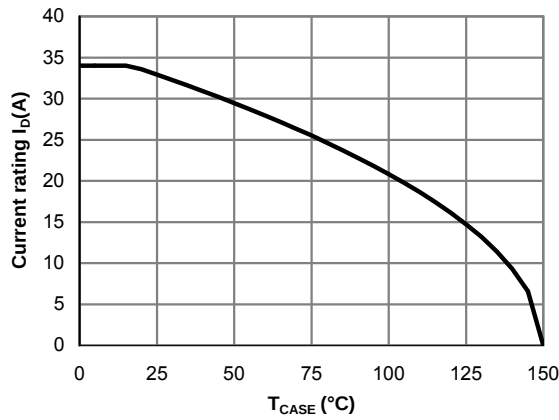


Figure 14: Current De-rating (Note F)

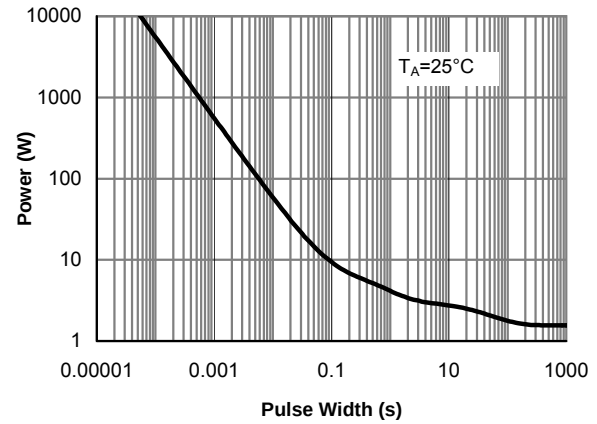


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

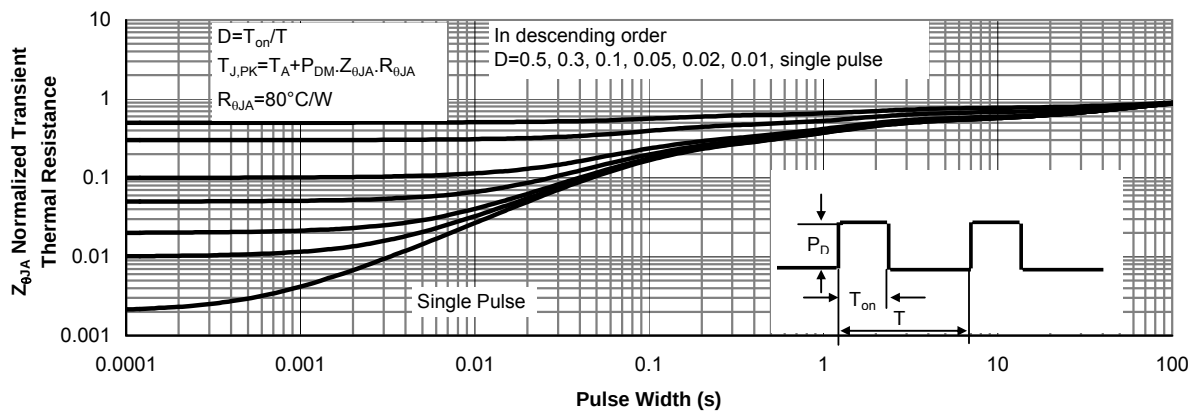
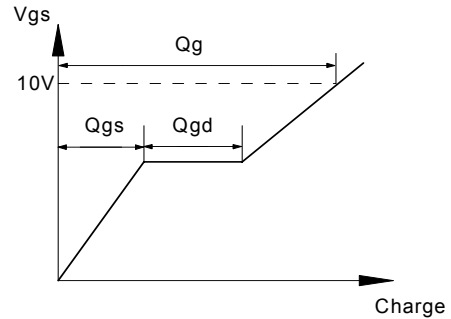
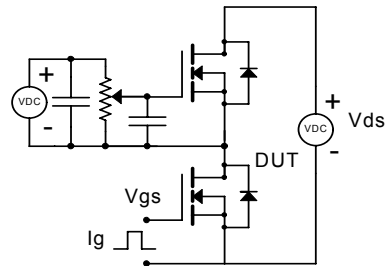
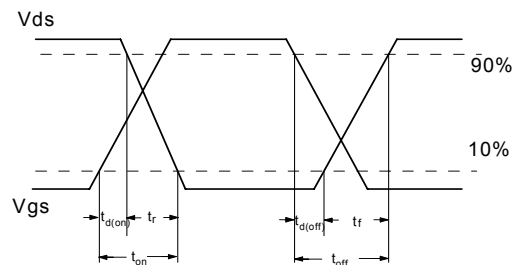
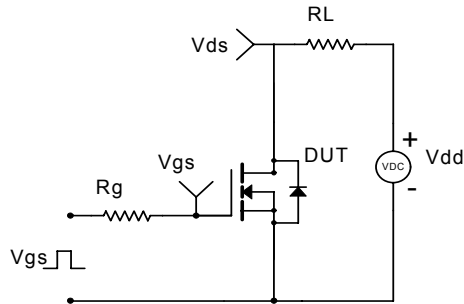


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

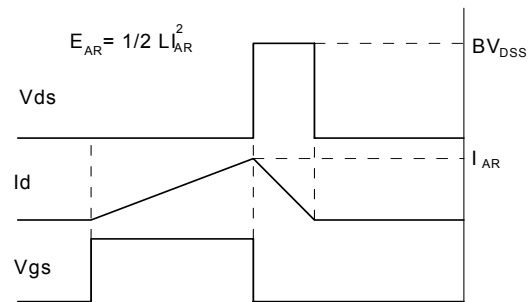
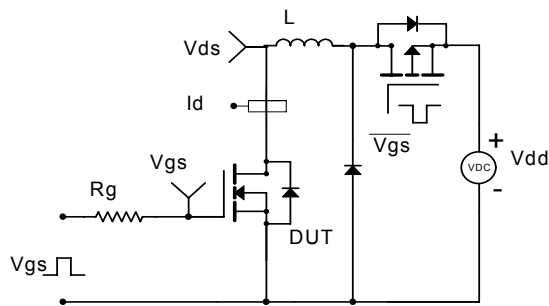
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

